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 Table S3 EDS analysis of the bottom layer in figure 2e

 Table S4 EDS analysis of the upper layer in figure 2g

Table S5 EDS analysis of the bottom layer in figure 2g

Table S6 Fire alarm performance comparison with other reported works

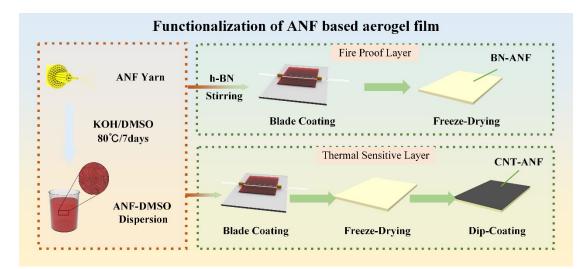


Figure S1 Preparation and functionalization process of LEGO® building blocks



Figure S2. The sample fabricated with small pressure



Figure S3. The sample fabricated with low temperature



Figure S4. The sample fabricated with high temperature

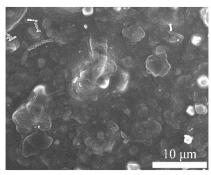


Figure S5 SEM image of the BN-ANF protective layer

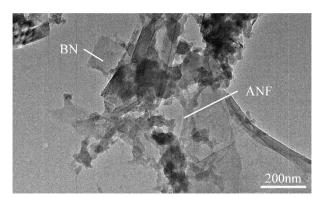
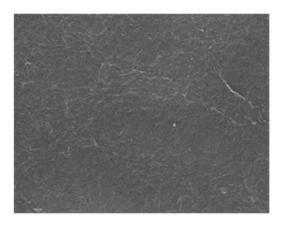


Figure S6. TEM image of BN-ANF



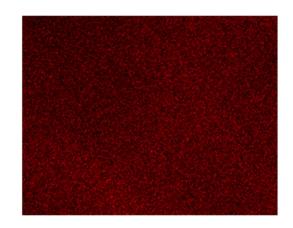


Figure S7. The SEM of BN-ANF and the Boron element mapping

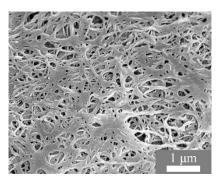


Figure S8 SEM image of the ANF base layer

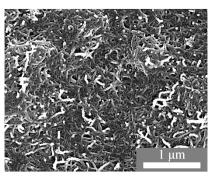


Figure S9 SEM image of the CNT conductive layer

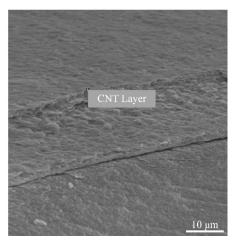


Figure S10 EDS analysis of the upper layer in figure 2e.

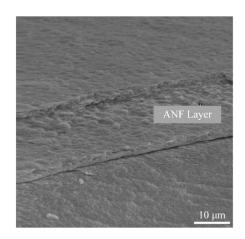


Figure S11 EDS analysis of the middle layer in figure 2e

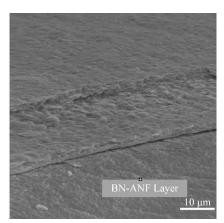


Figure S12 EDS analysis of the bottom layer in figure 2e

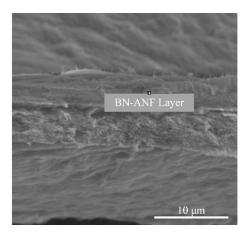


Figure S13 EDS analysis of the upper layer in figure 2g

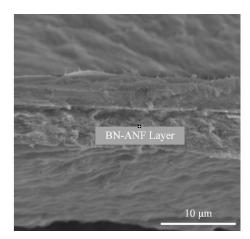


Figure S14 EDS analysis of the bottom layer in figure  $2 {\rm g}$ 



Figure S15 Photograph and graphic illustration of the ultrathin sample



Figure S16 Burning residuals of the samples with or without protection layer

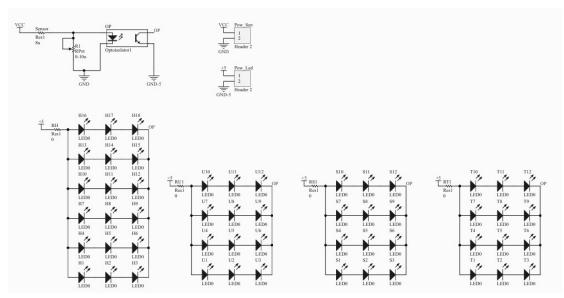


Figure S17 The schematic diagram of the fire alarm circuit



Figure S18 Electrical insulation properties of the samples with protection layer

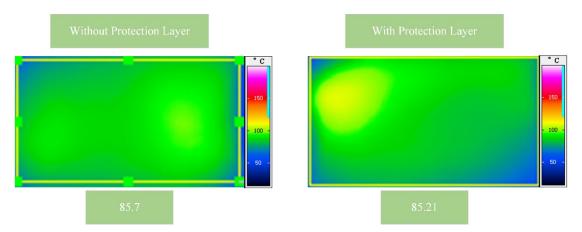


Figure S19 Surface Temperature Distribution with or without protection layer

## Table S1 EDS analysis of the upper layer in figure 2e

Element	Weight Percentage	ntage Atom Percentage	
Boron	0	0	
Carbon	100	100	

Table S2 EDS analysis of the middle layer in figure 2e

Element	Weight Percentage Atom Percentage	
Boron	0	0
Carbon	100	100

Table S3 EDS analysis of the bottom layer in figure 2e

Element	Weight Percentage	eight Percentage Atom Percentage	
Boron	7.75	8.53	
Carbon	92.25	91.47	

Table S4 EDS analysis of the upper layer in figure 2g

Element	Weight Percentage	Atom Percentage
Boron	8.6	9.47
Carbon	91.4	90.53

Table S5 EDS analysis of the bottom layer in figure 2g

Element	Weight Percentage	Percentage Atom Percentage	
Boron	0	0	
Carbon	100	100	

Table S6 Fire alarm performance comparison with other reported works<sup>1-6</sup>

Name	Response Time(s)	Duration(s)	Reference
SSFS	4	22	[1]
TA-MoS <sub>2</sub>	4.9	>1200	[2]
BCGP	3.6	>150	[3]
HTE@CF-4	3	>60	[4]
AM@Bamboo	5.3	120	[5]
GO-HNT	8	>1200	[6]
This Work	3	>1200	This work

## References

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